

**62 mm C-Series module with CoolSiC™ Trench MOSFET and pre-applied thermal interface material**

**Features**

- Electrical features
  - $V_{DS} = 2000\text{ V}$
  - $I_{DN} = 300\text{ A}$  /  $I_{DRM} = 600\text{ A}$
  - Low switching losses
  - High current density
- Mechanical features
  - 4 kV AC 1 min insulation
  - Pre-applied thermal interface material



**Potential applications**

- UPS systems
- DC/DC converter
- High-frequency switching application
- Solar applications

**Product validation**

- Qualified for industrial applications according to the relevant tests of IEC 60747, 60749 and 60068

**Description**

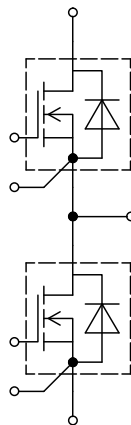


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## 1 Package

**Table 1** Insulation coordination

| Parameter                           | Symbol      | Note or test condition                         | Values    | Unit |
|-------------------------------------|-------------|--|-----------|------|
| Isolation test voltage              | $V_{ISOL}$  | RMS, $f = 50 \text{ Hz}$ , $t = 1 \text{ min}$ | 4.0       | kV   |
| Material of module baseplate        |             |  | Cu        |      |
| Internal isolation                  |             | basic insulation (class 1, IEC 61140)          | $Al_2O_3$ |      |
| Creepage distance                   | $d_{Creep}$ | terminal to heatsink                           | 29.0      | mm   |
| Creepage distance                   | $d_{Creep}$ | terminal to terminal                           | 23.0      | mm   |
| Clearance                           | $d_{Clear}$ | terminal to heatsink                           | 23.0      | mm   |
| Clearance                           | $d_{Clear}$ | terminal to terminal                           | 11.0      | mm   |
| Comparative tracking index          | $CTI$       |  | > 400     |      |
| Relative thermal index (electrical) | $RTI$       | housing  | 140       | °C   |

**Table 2** Characteristic values

| Parameter                                | Symbol        | Note or test condition                         |           | Values |       |      | Unit |
|--|---------------|--|-----------|--------|-------|------|------|
|  |               |  |           | Min.   | Typ.  | Max. |      |
| Stray inductance module                  | $L_{sCE}$     |  |           |        | 20    |      | nH   |
| Module lead resistance, terminals - chip | $R_{CC'+EE'}$ | T <sub>C</sub> = 25 °C, per switch             |           |        | 0.475 |      | mΩ   |
| Storage temperature                      | $T_{stg}$     |  |           | -40    |       | 125  | °C   |
| Maximum baseplate operation temperature  | $T_{BPmax}$   |  |           |        |       | 125  | °C   |
| Mounting torque for module mounting      | $M$           | - Mounting according to valid application note | M6, Screw | 3      |       | 6    | Nm   |
| Terminal connection torque               | $M$           | - Mounting according to valid application note | M6, Screw | 2.5    |       | 5    | Nm   |
| Weight                                   | $G$           |  |           |        | 340   |      | g    |

Note: Storage and shipment of modules with TIM => see AN2012-07

## 2 MOSFET, T1 / T2

**Table 3** Maximum rated values

| Parameter                 | Symbol    | Note or test condition   | Values | Unit |
|---------------------------|-----------|--------------------------|--------|------|
| Drain-source voltage      | $V_{DSS}$ | $T_{vj} = 25 \text{ °C}$ | 2000   | V    |
| Implemented drain current | $I_{DN}$  |                          | 300    | A    |

(table continues...)

**Table 3 (continued) Maximum rated values**

| Parameter                                   | Symbol           | Note or test condition   |                               | Values | Unit |
|---|------------------|--|-------------------------------|--------|------|
| Continuous DC drain current                 | $I_{\text{DDC}}$ | $T_{\text{vj}} = 175\text{ °C}$ , $V_{\text{GS}} = 18\text{ V}$  | $T_{\text{H}} = 25\text{ °C}$ | 245    | A    |
| Repetitive peak drain current               | $I_{\text{DRM}}$ | verified by design, $t_{\text{p}}$ limited by $T_{\text{vjmax}}$ |                               | 600    | A    |
| Gate-source voltage, max. transient voltage | $V_{\text{GS}}$  | $D < 0.01$   |                               | -10/23 | V    |
| Gate-source voltage, max. static voltage    | $V_{\text{GS}}$  |  |                               | -7/20  | V    |

**Table 4 Recommended values**

| Parameter              | Symbol               | Note or test condition | Values | Unit |
|------------------------|----------------------|------------------------|--------|------|
| On-state gate voltage  | $V_{\text{GS(on)}}$  |                        | 18     | V    |
| Off-state gate voltage | $V_{\text{GS(off)}}$ |                        | -3     | V    |

**Table 5 Characteristic values**

| Parameter                      | Symbol              | Note or test condition  |  | Values |       |      | Unit |
|--------------------------------|---------------------|---|--|--------|-------|------|------|
|                                |                     |   |  | Min.   | Typ.  | Max. |      |
| Drain-source on-resistance     | $R_{\text{DS(on)}}$ | $I_{\text{D}} = 300\text{ A}$   | $V_{\text{GS}} = 18\text{ V}$ ,<br>$T_{\text{vj}} = 25\text{ °C}$  |        | 3.5   | 5.3  | mΩ   |
|                                |                     |   | $V_{\text{GS}} = 18\text{ V}$ ,<br>$T_{\text{vj}} = 125\text{ °C}$ |        | 7.3   |      |      |
|                                |                     |   | $V_{\text{GS}} = 18\text{ V}$ ,<br>$T_{\text{vj}} = 175\text{ °C}$ |        | 10.4  |      |      |
| Gate threshold voltage         | $V_{\text{GS(th)}}$ | $I_{\text{D}} = 168\text{ mA}$ , $V_{\text{DS}} = V_{\text{GS}}$ , $T_{\text{vj}} = 25\text{ °C}$ , (tested after 1ms pulse at $V_{\text{GS}} = +20\text{ V}$ ) |  | 3.45   | 4.3   | 5.15 | V    |
| Total gate charge              | $Q_{\text{G}}$      | $V_{\text{DD}} = 1200\text{ V}$ , $V_{\text{GS}} = -3/18\text{ V}$  |  |        | 1.17  |      | μC   |
| Internal gate resistor         | $R_{\text{Gint}}$   | $T_{\text{vj}} = 25\text{ °C}$  |  |        | 1.2   |      | Ω    |
| Input capacitance              | $C_{\text{ISS}}$    | $f = 100\text{ kHz}$ , $V_{\text{DS}} = 1200\text{ V}$ ,<br>$V_{\text{GS}} = 0\text{ V}$  | $T_{\text{vj}} = 25\text{ °C}$                                     |        | 36.1  |      | nF   |
| Output capacitance             | $C_{\text{OSS}}$    | $f = 100\text{ kHz}$ , $V_{\text{DS}} = 1200\text{ V}$ ,<br>$V_{\text{GS}} = 0\text{ V}$  | $T_{\text{vj}} = 25\text{ °C}$                                     |        | 0.845 |      | nF   |
| Reverse transfer capacitance   | $C_{\text{rss}}$    | $f = 100\text{ kHz}$ , $V_{\text{DS}} = 1200\text{ V}$ ,<br>$V_{\text{GS}} = 0\text{ V}$  | $T_{\text{vj}} = 25\text{ °C}$                                     |        | 0.061 |      | nF   |
| $C_{\text{OSS}}$ stored energy | $E_{\text{OSS}}$    | $V_{\text{DS}} = 1200\text{ V}$ , $V_{\text{GS}} = -3/18\text{ V}$ , $T_{\text{vj}} = 25\text{ °C}$   |  |        | 1520  |      | μJ   |
| Drain-source leakage current   | $I_{\text{DSS}}$    | $V_{\text{DS}} = 2000\text{ V}$ , $V_{\text{GS}} = -3\text{ V}$   | $T_{\text{vj}} = 25\text{ °C}$                                     |        | 0.06  | 527  | μA   |
| Gate-source leakage current    | $I_{\text{GSS}}$    | $V_{\text{DS}} = 0\text{ V}$ , $T_{\text{vj}} = 25\text{ °C}$   | $V_{\text{GS}} = 20\text{ V}$                                      |        |       | 400  | nA   |

(table continues...)

**Table 5** (continued) **Characteristic values**

| Parameter                                    | Symbol       | Note or test condition  | Values                   |      |       | Unit       |
|--|--------------|---|--------------------------|------|-------|------------|
|  |              |   | Min.                     | Typ. | Max.  |            |
| Turn-on delay time<br>(inductive load)       | $t_{d\ on}$  | $I_D = 300\ A, R_{Gon} = 7.1\ \Omega,$<br>$V_{DD} = 1200\ V,$<br>$V_{GS} = -3/18\ V$  | $T_{vj} = 25\ ^\circ C$  | 204  |       | ns         |
|  |              |   | $T_{vj} = 125\ ^\circ C$ | 187  |       |            |
|  |              |   | $T_{vj} = 175\ ^\circ C$ | 181  |       |            |
| Rise time (inductive load)                   | $t_r$        | $I_D = 300\ A, R_{Gon} = 7.1\ \Omega,$<br>$V_{DD} = 1200\ V,$<br>$V_{GS} = -3/18\ V$  | $T_{vj} = 25\ ^\circ C$  | 219  |       | ns         |
|  |              |   | $T_{vj} = 125\ ^\circ C$ | 195  |       |            |
|  |              |   | $T_{vj} = 175\ ^\circ C$ | 194  |       |            |
| Turn-off delay time<br>(inductive load)      | $t_{d\ off}$ | $I_D = 300\ A, R_{Goff} = 4.3\ \Omega,$<br>$V_{DD} = 1200\ V,$<br>$V_{GS} = -3/18\ V$   | $T_{vj} = 25\ ^\circ C$  | 256  |       | ns         |
|  |              |   | $T_{vj} = 125\ ^\circ C$ | 282  |       |            |
|  |              |   | $T_{vj} = 175\ ^\circ C$ | 296  |       |            |
| Fall time (inductive load)                   | $t_f$        | $I_D = 300\ A, R_{Goff} = 4.3\ \Omega,$<br>$V_{DD} = 1200\ V,$<br>$V_{GS} = -3/18\ V$   | $T_{vj} = 25\ ^\circ C$  | 80.3 |       | ns         |
|  |              |   | $T_{vj} = 125\ ^\circ C$ | 82.1 |       |            |
|  |              |   | $T_{vj} = 175\ ^\circ C$ | 84.2 |       |            |
| Turn-on energy loss per<br>pulse             | $E_{on}$     | $I_D = 300\ A, V_{DD} = 1200\ V,$<br>$L_\sigma = 25\ nH, V_{GS} = -3/18\ V,$<br>$R_{Gon} = 7.1\ \Omega, di/dt = 3.4$<br>$kA/\mu s (T_{vj} = 175\ ^\circ C)$   | $T_{vj} = 25\ ^\circ C$  | 45.5 |       | mJ         |
|  |              |   | $T_{vj} = 125\ ^\circ C$ | 46.5 |       |            |
|  |              |   | $T_{vj} = 175\ ^\circ C$ | 50.5 |       |            |
| Turn-off energy loss per<br>pulse            | $E_{off}$    | $I_D = 300\ A, V_{DD} = 1200\ V,$<br>$L_\sigma = 25\ nH, V_{GS} = -3/18\ V,$<br>$R_{Goff} = 4.3\ \Omega, dv/dt = 11.4$<br>$kV/\mu s (T_{vj} = 175\ ^\circ C)$ | $T_{vj} = 25\ ^\circ C$  | 23.7 |       | mJ         |
|  |              |   | $T_{vj} = 125\ ^\circ C$ | 24.5 |       |            |
|  |              |   | $T_{vj} = 175\ ^\circ C$ | 25.2 |       |            |
| Thermal resistance,<br>junction to heat sink | $R_{thJH}$   | per MOSFET, Valid with IFX pre-applied<br>Thermal Interface Material  |                          |      | 0.153 | K/W        |
| Temperature under<br>switching conditions    | $T_{vj\ op}$ |   | -40                      |      | 175   | $^\circ C$ |

**Note:** The selection of positive and negative gate-source voltages impacts losses and the long-term behavior of the MOSFET and body diode. The design guidelines described in Application Notes AN 2018-09 and AN 2021-13 must be considered to ensure sound operation of the device over the planned lifetime.

$T_{vj,op} > 150\ ^\circ C$  is allowed for operation at overload conditions for MOSFET and body diode. For detailed specifications, please refer to AN 2021-13.

### 3 Body diode (MOSFET, T1 / T2)

**Table 6** **Maximum rated values**

| Parameter                        | Symbol   | Note or test condition   | Values | Unit |
|----------------------------------|----------|--|--------|------|
| DC body diode forward<br>current | $I_{SD}$ | $T_{vj} = 175\ ^\circ C, V_{GS} = -3\ V$<br>$T_H = 25\ ^\circ C$ | 180    | A    |

**Table 7**                      **Characteristic values**

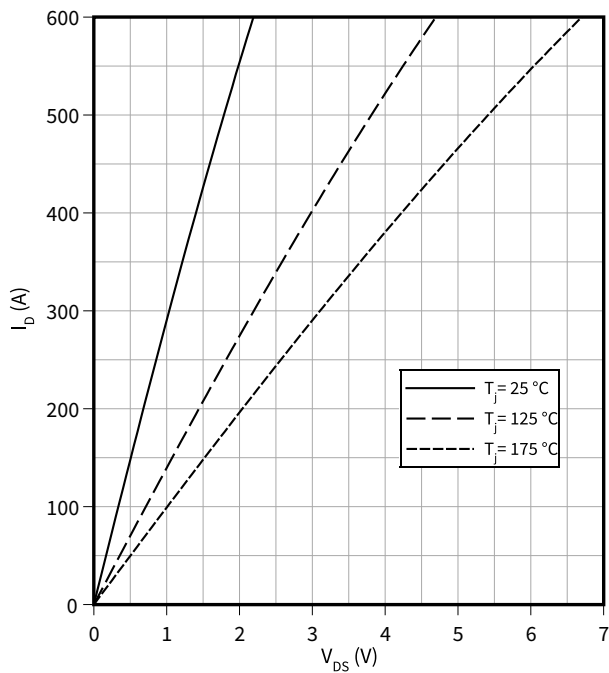
| Parameter       | Symbol   | Note or test condition                             |                           | Values |      |      | Unit |
|-----------------|----------|--|---------------------------|--------|------|------|------|
|                 |          |  |                           | Min.   | Typ. | Max. |      |
| Forward voltage | $V_{SD}$ | $I_{SD} = 300 \text{ A}$ , $V_{GS} = -3 \text{ V}$ | $T_{vj} = 25 \text{ °C}$  |        | 4.6  | 6.15 | V    |
|                 |          |  | $T_{vj} = 125 \text{ °C}$ |        | 4.15 |      |      |
|                 |          |  | $T_{vj} = 175 \text{ °C}$ |        | 4    |      |      |

4 Characteristics diagrams

Output characteristic (typical), MOSFET, T1 / T2

$I_D = f(V_{DS})$

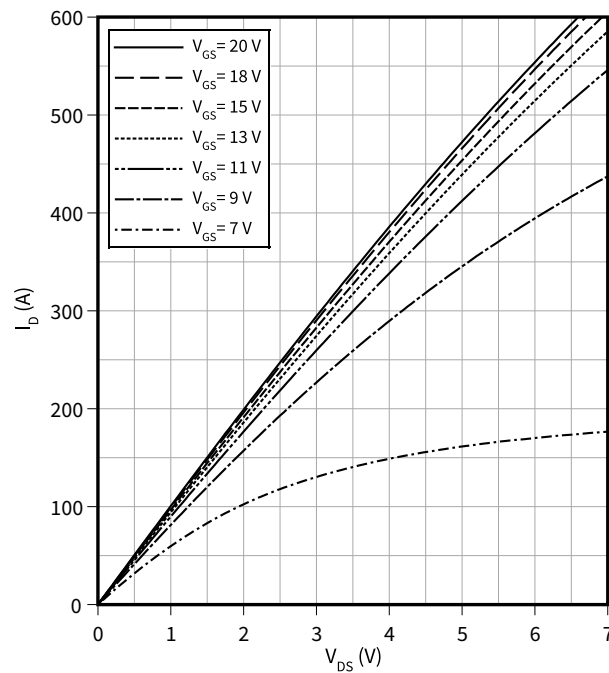
$V_{GS} = 18\text{ V}$



Output characteristic field (typical), MOSFET, T1 / T2

$I_D = f(V_{DS})$

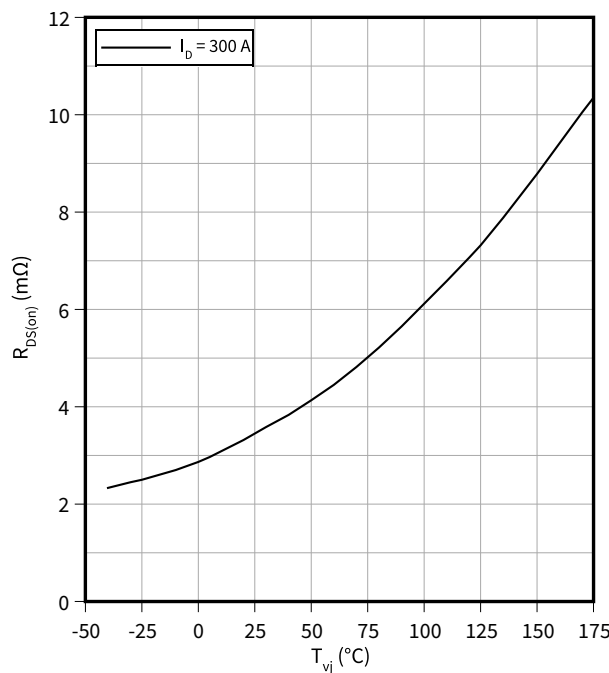
$T_{vj} = 175\text{ °C}$



Drain source on-resistance (typical), MOSFET, T1 / T2

$R_{DS(on)} = f(T_{vj})$

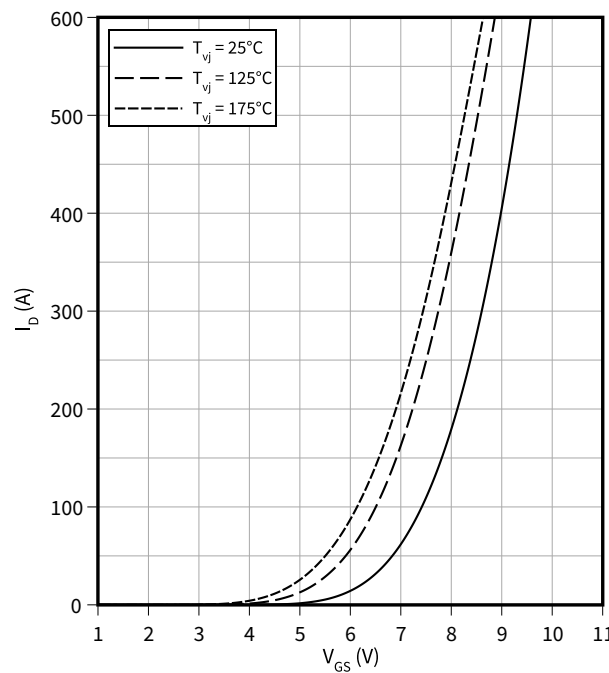
$V_{GS} = 18\text{ V}$



Transfer characteristic (typical), MOSFET, T1 / T2

$I_D = f(V_{GS})$

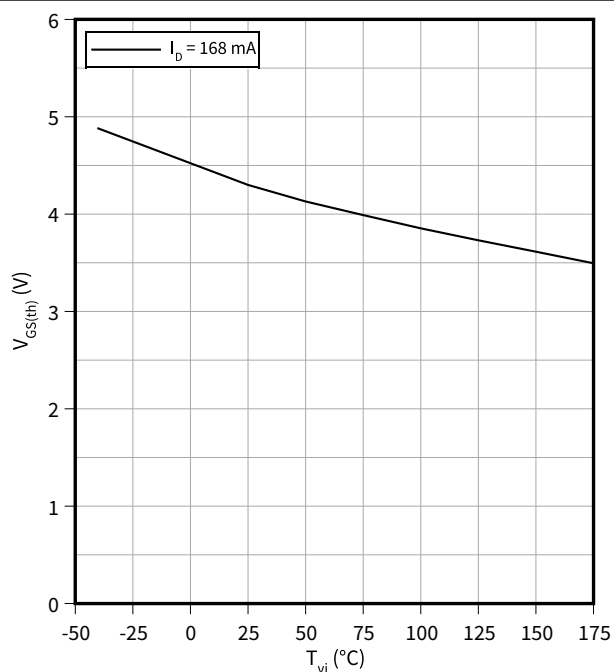
$V_{DS} = 20\text{ V}$



**Gate-source threshold voltage (typical), MOSFET, T1 / T2**

$$V_{GS(th)} = f(T_{vj})$$

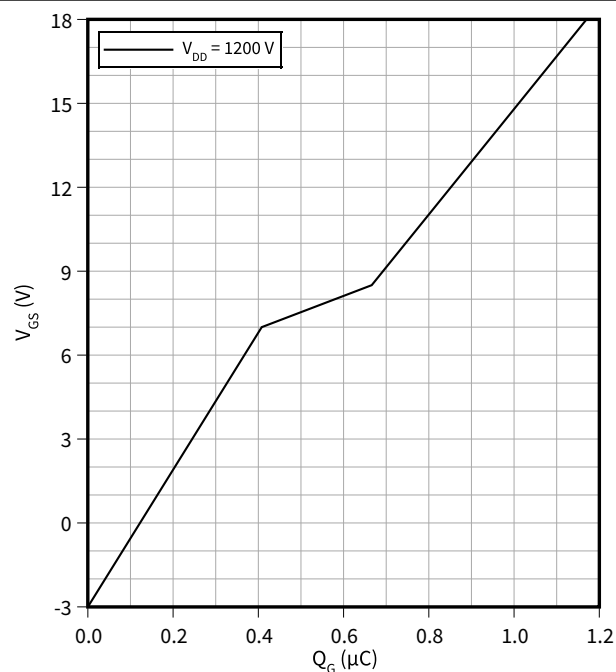
$$V_{GS} = V_{DS}$$



**Gate charge characteristic (typical), MOSFET, T1 / T2**

$$V_{GS} = f(Q_G)$$

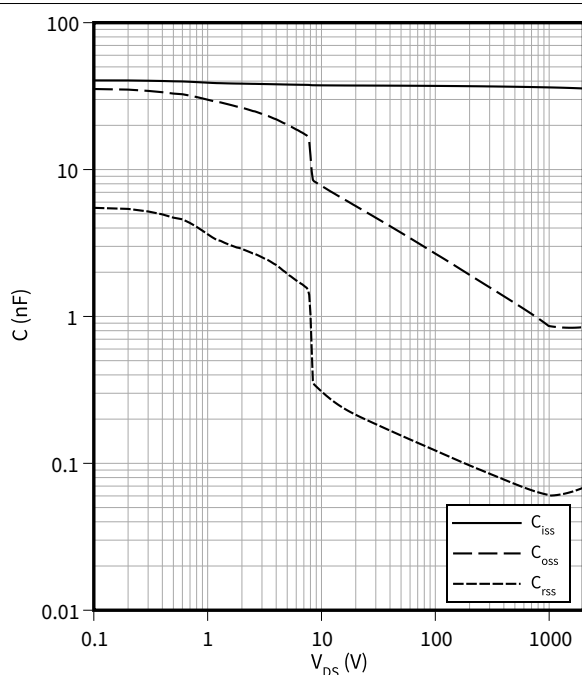
$$I_D = 300 \text{ A}, T_{vj} = 25 \text{ °C}$$



**Capacity characteristic (typical), MOSFET, T1 / T2**

$$C = f(V_{DS})$$

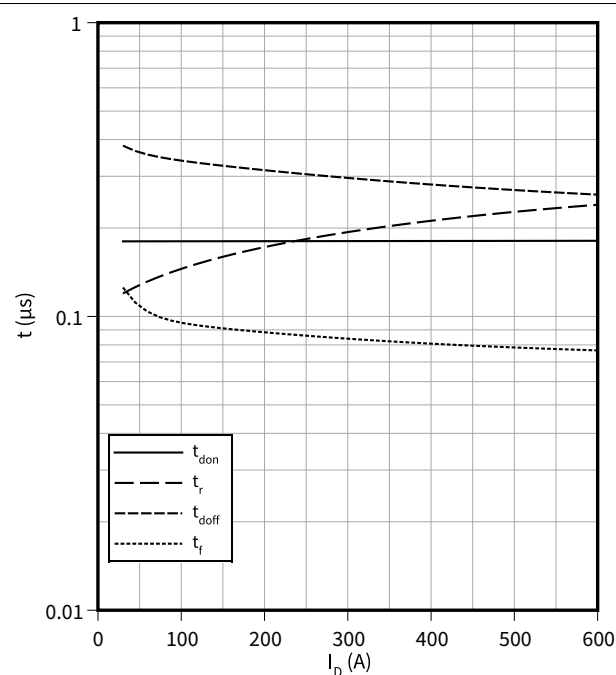
$$f = 100 \text{ kHz}, T_{vj} = 25 \text{ °C}, V_{GS} = 0 \text{ V}$$



**Switching times (typical), MOSFET, T1 / T2**

$$t = f(I_D)$$

$$R_{Goff} = 4.3 \text{ } \Omega, R_{Gon} = 7.1 \text{ } \Omega, V_{DD} = 1200 \text{ V}, T_{vj} = 175 \text{ °C}, V_{GS} = -3/18 \text{ V}$$

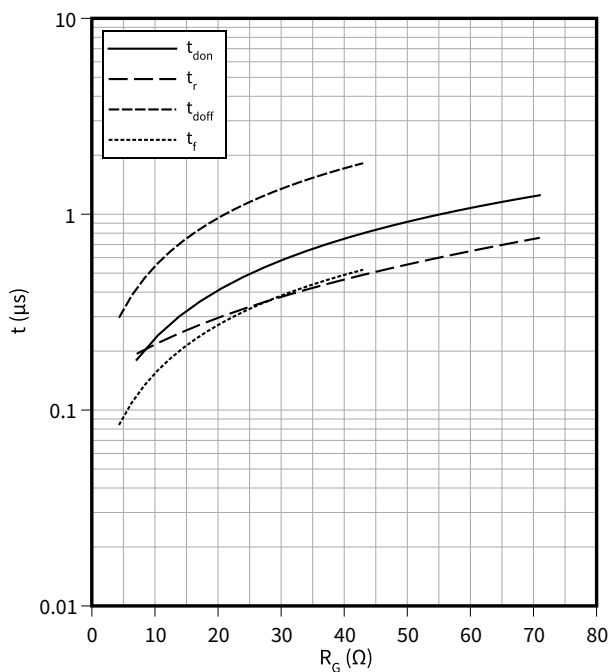




**Switching times (typical), MOSFET, T1 / T2**

$$t = f(R_G)$$

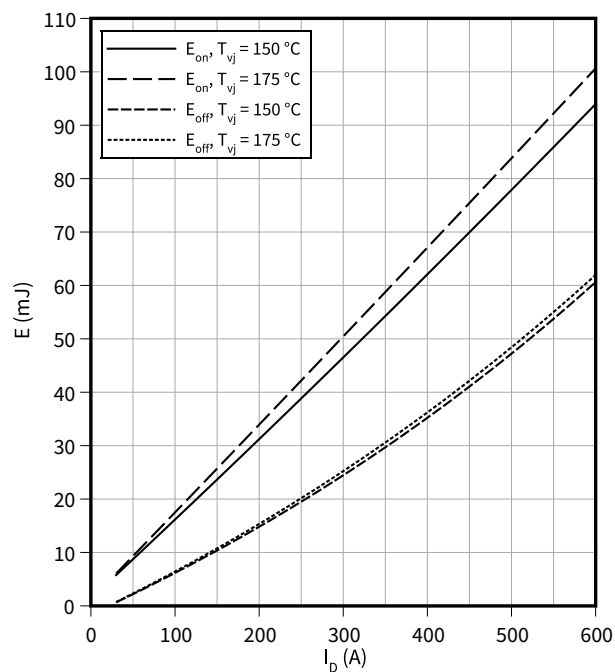
$V_{DD} = 1200 \text{ V}$ ,  $I_D = 300 \text{ A}$ ,  $T_{vj} = 175 \text{ }^\circ\text{C}$ ,  $V_{GS} = -3/18 \text{ V}$



**Switching losses (typical), MOSFET, T1 / T2**

$$E = f(I_D)$$

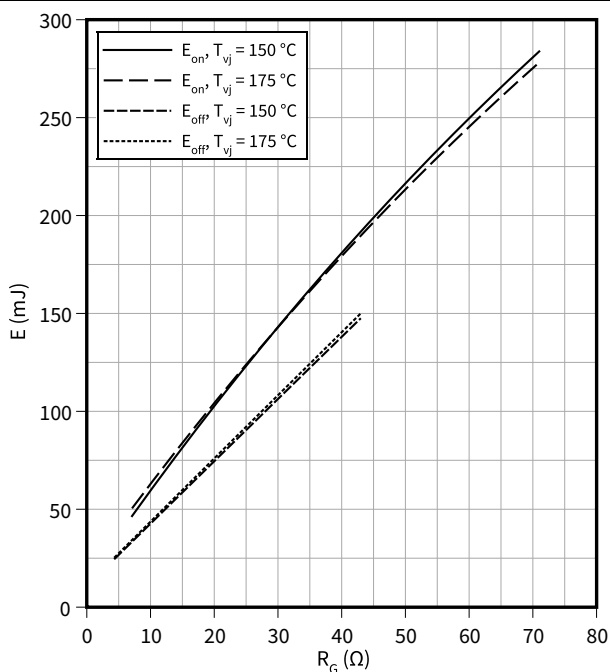
$R_{Goff} = 4.3 \text{ } \Omega$ ,  $R_{Gon} = 7.1 \text{ } \Omega$ ,  $V_{DD} = 1200 \text{ V}$ ,  $V_{GS} = -3/18 \text{ V}$



**Switching losses (typical), MOSFET, T1 / T2**

$$E = f(R_G)$$

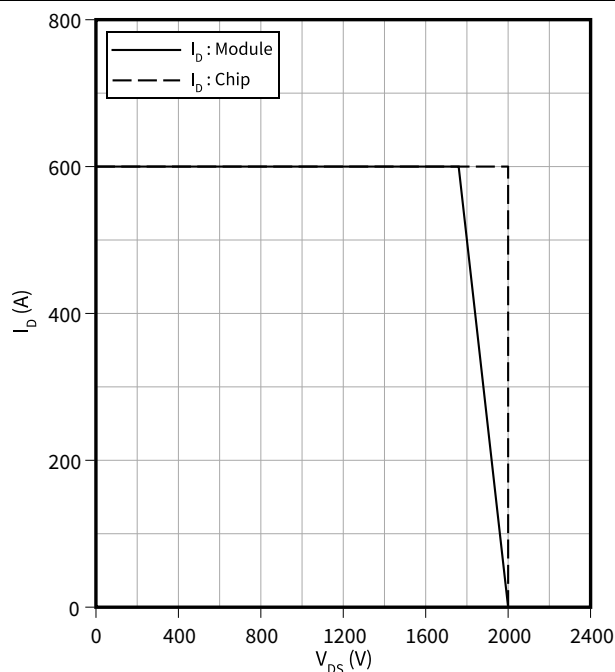
$V_{DD} = 1200 \text{ V}$ ,  $I_D = 300 \text{ A}$ ,  $V_{GS} = -3/18 \text{ V}$



**Reverse bias safe operating area (RBSOA), MOSFET, T1 / T2**

$$I_D = f(V_{DS})$$

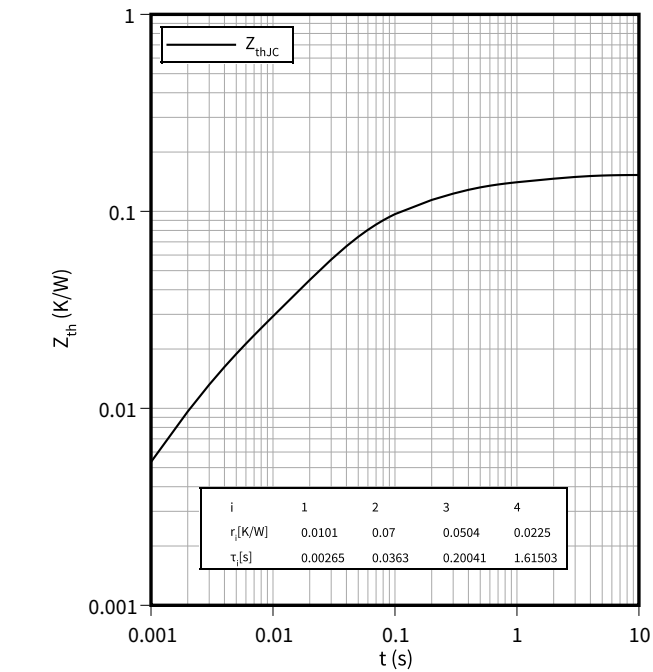
$R_{Goff} = 4.3 \text{ } \Omega$ ,  $T_{vj} = 175 \text{ }^\circ\text{C}$ ,  $V_{GS} = -3/18 \text{ V}$



4 Characteristics diagrams

Transient thermal impedance , MOSFET, T1 / T2

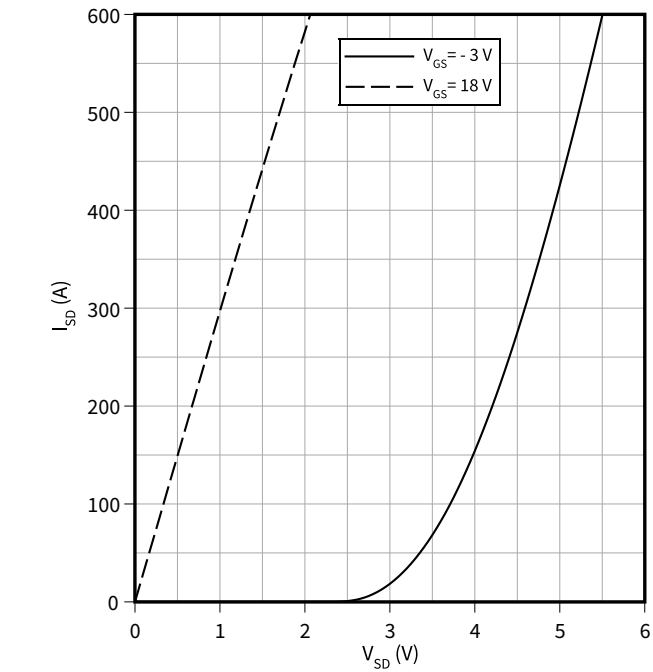
$Z_{th} = f(t)$



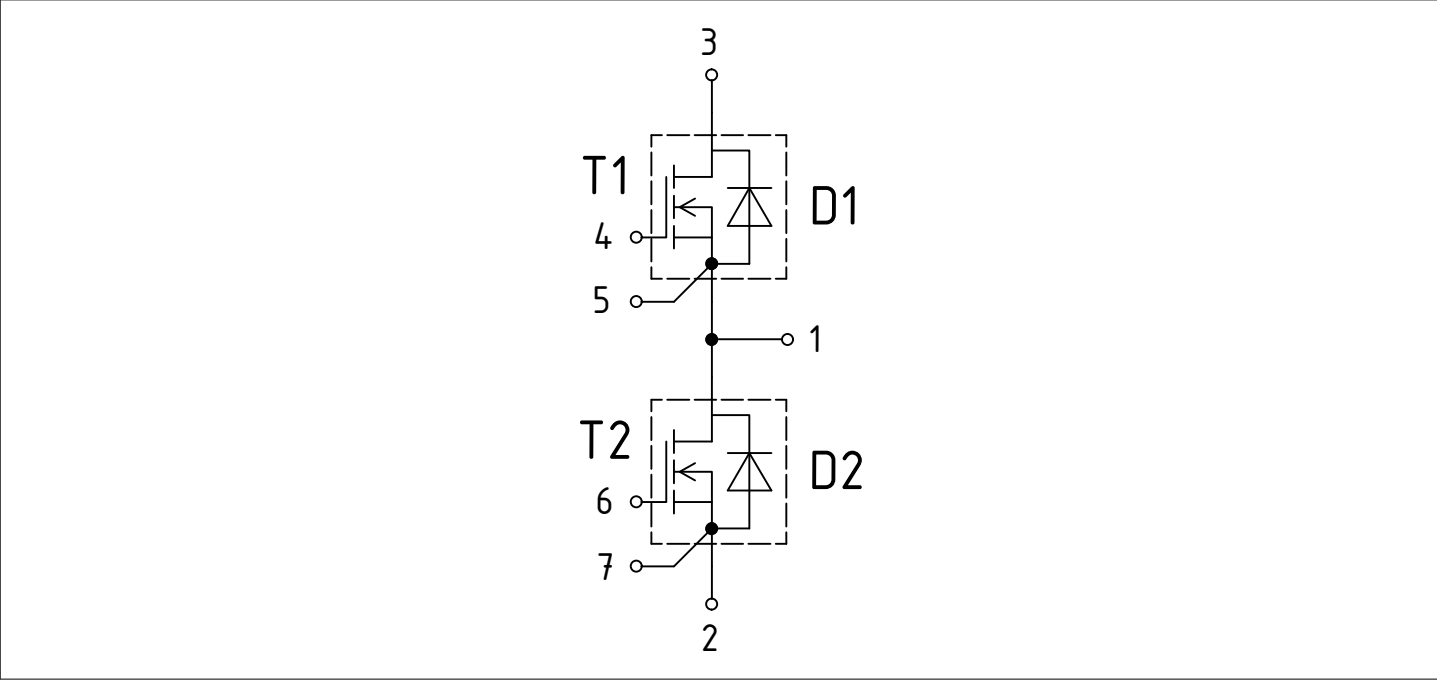
Forward characteristic body diode (typical), MOSFET, T1 / T2

$I_{SD} = f(V_{SD})$

$T_{vj} = 25\text{ }^{\circ}\text{C}$

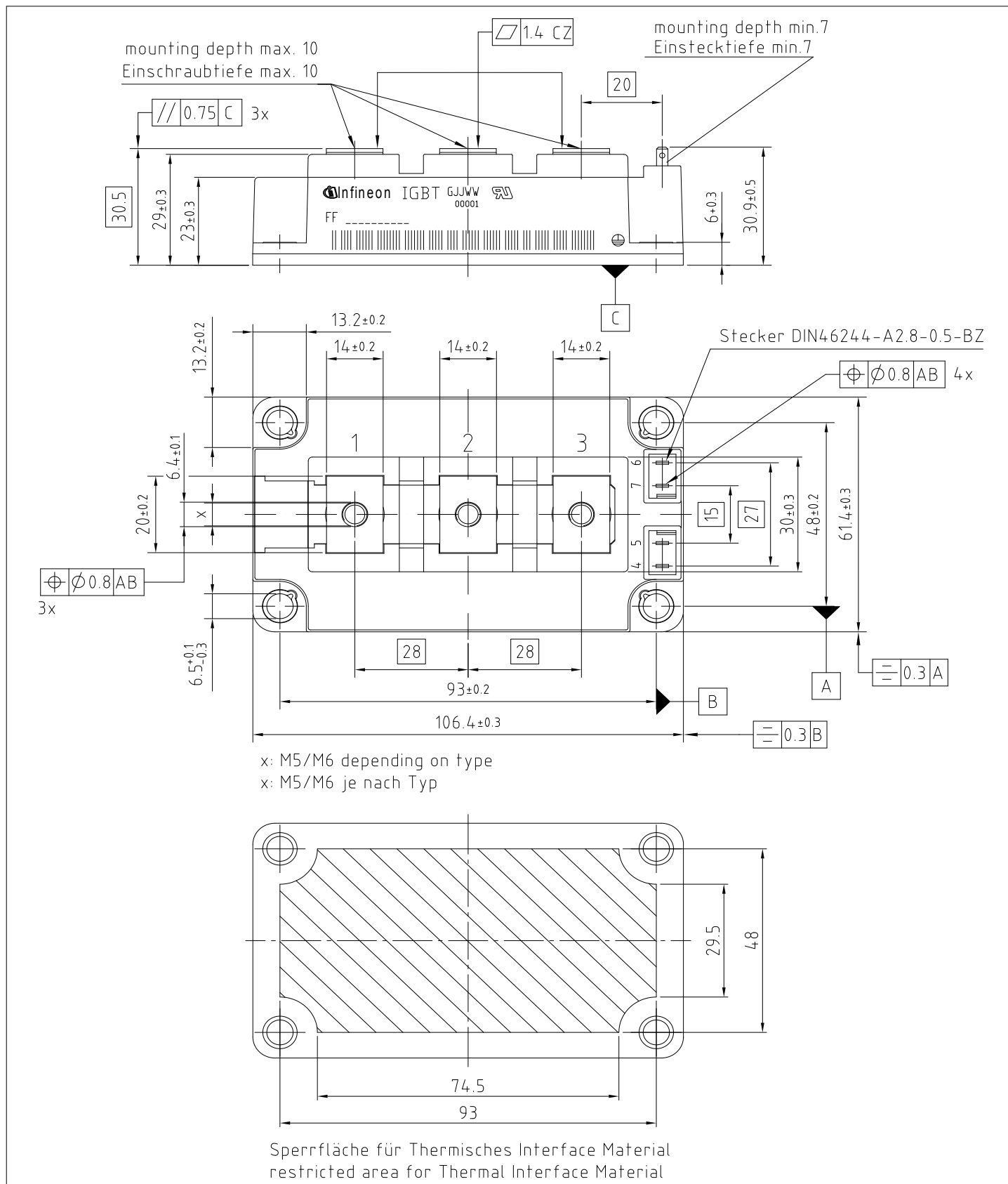


5      **Circuit diagram**



**Figure 1**

## 6 Package outlines



**Figure 2**

7 Module label code



| Module label code |  |              |                 |
|-------------------|--|--------------|-----------------|
| Code format       | Data Matrix  |              | Barcode Code128 |
| Encoding          | ASCII text   |              | Code Set A      |
| Symbol size       | 16x16  |              | 23 digits       |
| Standard          | IEC24720 and IEC16022  |              | IEC8859-1       |
| Code content      | <i>Content</i>   | <i>Digit</i> | <i>Example</i>  |
|                   | Module serial number   | 1 – 5        | 71549           |
|                   | Module material number   | 6 - 11       | 142846          |
|                   | Production order number  | 12 - 19      | 55054991        |
|                   | Date code (production year)  | 20 – 21      | 15              |
|                   | Date code (production week)  | 22 – 23      | 30              |
| Example           | <div><br/>71549142846550549911530</div> <div><br/>71549142846550549911530</div> |              |                 |

Figure 3



Revision history

Revision history

| Document revision | Date of release | Description of changes |
|-------------------|-----------------|------------------------|
| 1.00              | 2023-05-05      | Initial version        |

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